

Listing of Claims:

This listing of claims will replace all prior versions, and listings, of claims in the application:

- 5 1. (Previously presented) An X-ray microscope which includes a device for generating X-rays, a lens for forming an image of an object, and an X-ray detector for detecting an image of the object, the device for generating X-rays provided with:
 - means for producing a fluid jet having a curvilinear cross-section,
 - means for forming a focused radiation beam whose focus is situated on the fluid jet,
said focused radiation beam comprising a beam of electrically charged particles.
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- 15 2. (Previously presented) An X-ray microscope as claimed in Claim 1, wherein the beam of electrically charged particles comprises an electron beam.
- 20 3. (Previously presented) An X-ray microscope as claimed in Claim 1, wherein the cross-section of the fluid jet in the direction of the focused beam is smaller than that in the direction transversely thereof.
- 25 4. (Previously presented) An X-ray microscope as claimed in Claim 1, wherein the fluid jet consists essentially of liquid oxygen or nitrogen.

5. (Previously presented) An X-ray microscope as claimed in
Claim 1, wherein the means for producing a focused beam of
electrically charged particles comprises an electron gun for a
cathode ray tube, the X-ray microscope including a condensér
5 lens disposed between the fluid jet and an object to be imaged
by means of the X-ray microscope.

6. (Previously presented) An electron microscope comprising
means for producing a focused electron beam, a device for
10 generating X-rays, a lens for forming an image of an object,
and a detector for detecting the image of the object,
said device for generating X-rays including:
15 • means for producing a fluid jet having a curvilinear
 cross-section, and
 • means for directing the focus of the electron beam onto
 the fluid jet.

7. (Previously presented) An electron microscope as claimed in
Claim 6 and including an X-ray microscope, said device for
20 generating X-rays acting as the X-ray source for the X-ray
microscope.

8. (Previously presented) An electron microscope as claimed in
Claim 6, the electron microscope being a scanning electron
25 microscope.